



CHENMKO ENTERPRISE CO.,LTD

2N7002TESGP

SURFACE MOUNT

N-Channel Enhancement Mode Field Effect Transistor

VOLTAGE 60 Volts CURRENT 115 mAmpere

Halogens free devices

APPLICATION

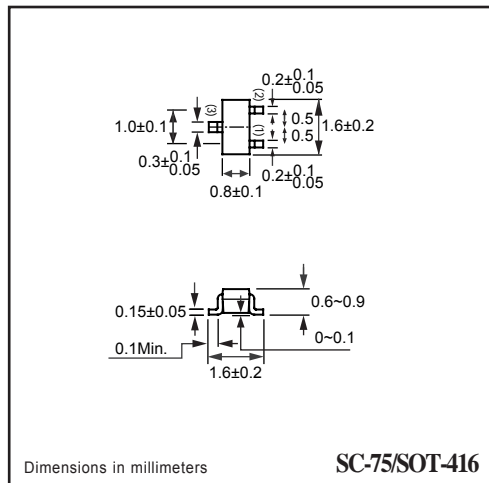
- * Relay driver
- * High speed line driver
- * Logic level transistor

FEATURE

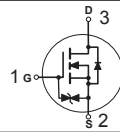
- * Small surface mounting type. (SC-75/SOT-416)
- * High density cell design for low R_{DS(ON)}.
- * Suitable for high packing density.
- * Rugged and reliable.
- * High saturation current capability.
- * ESD protect in input gate 1.5KV



SC-75/SOT-416



CIRCUIT



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	2N7002TESGP	Units
V _{DSS}	Drain-Source Voltage	60	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Maximum Drain Current - Continuous	115	mA
	- Pulsed (Note 1)	800	
P _D	Maximum Power Dissipation (Note 2)	225	mW
T _J	Operating Temperature Range	-55 to 150	°C
T _{STG}	Storage Temperature Range	-55 to 150	°C

Note : 1. P_w <= 10uS , Duty <= 1%
 2. When mounted on a 1*0.75*0.062 inch glass epoxy board.

ELECTRICAL CHARACTERISTIC (2N7002TESGP)

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
--------	-----------	------------	-----	-----	-----	-------

OFF CHARACTERISTICS

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 10\ \mu\text{A}$	60			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$			1	μA
					0.5	mA
I_{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			10	μA
I_{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-10	μA

ON CHARACTERISTICS (Note 1)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	1.0	1.5	2.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance (Note 3)	$V_{GS} = 5\text{ V}, I_D = 50\text{ mA}$ $V_{GS} = 10\text{ V}, I_D = 500\text{ mA}$			7.5	Ω
					7.5	
g_{FS}	Forward Transconductance (Note 3)	$V_{DS} = 10\text{ V}, I_D = 200\text{ mA}$	80			mS

DYNAMIC CHARACTERISTICS

C_{iss}	Input Capacitance	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$		25	50	pF
C_{oss}	Output Capacitance			10	25	
C_{rss}	Reverse Transfer Capacitance			3.0	5	
t_{on}	Turn-On Time (Note 3)	$V_{DD} = 30\text{ V}, R_L = 150\ \Omega,$ $I_D = 200\text{ mA}, V_{gen} = 10\text{ V},$ $R_{GEN} = 10\ \Omega$		12	20	nS
t_r	Turn-Off Time (Note 3)			20	30	

Note:
3. Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 1.0\%$.

RATING CHARACTERISTIC CURVES (2N7002ESGP)

Typical Electrical Characteristics

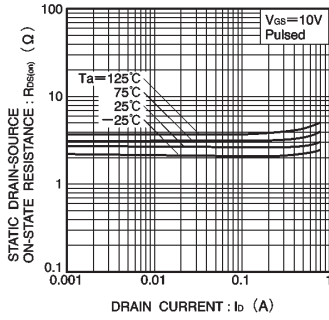


Fig.4 Static drain-source on-state resistance vs. drain current (I)

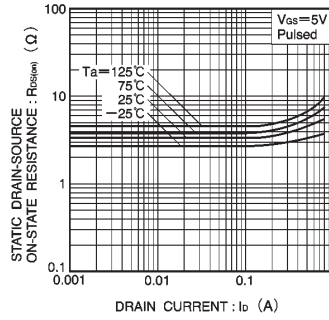


Fig.5 Static drain-source on-state resistance vs. drain current (II)

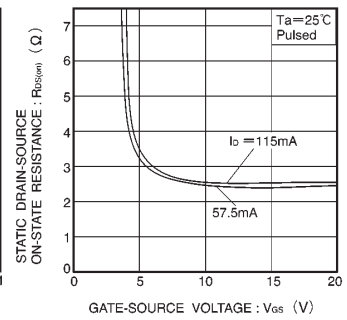


Fig.6 Static drain-source on-state resistance vs. gate-source voltage

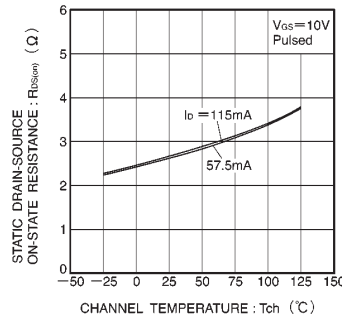


Fig.7 Static drain-source on-state resistance vs. channel temperature

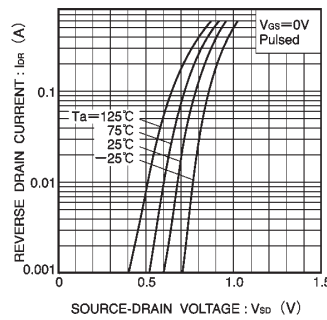


Fig.8 Reverse drain current vs. source-drain voltage (I)

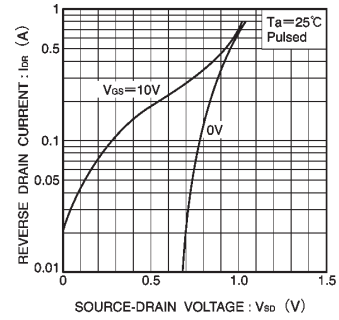


Fig.9 Reverse drain current vs. source-drain voltage (II)

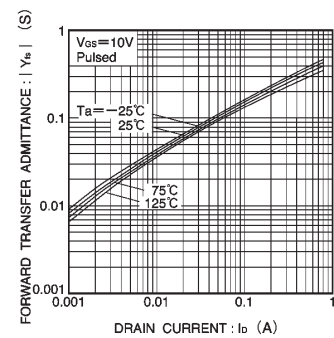


Fig.10 Forward transfer admittance vs. drain current

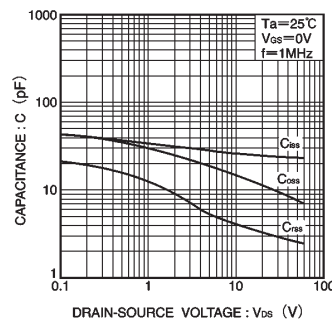


Fig.11 Typical capacitance vs. drain-source voltage

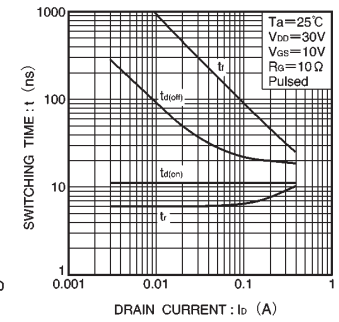


Fig.12 Switching characteristics (See Figures 13 and 14 for the measurement circuit and resultant waveforms)